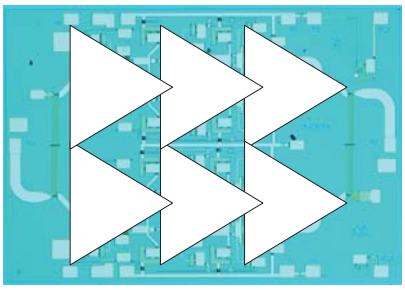
AMMC-6440

37 - 42 GHz Power Amplifier

Data Sheet



Chip Size: 2500 x 1750 µm (100 x 69 mils)
Chip Size Tolerance: ± 10 µm (±0.4 mils)
Chip Thickness: 100 ± 10 µm (4 ± 0.4 mils)
Pad Dimensions: 100 x 100 µm (4 ± 0.4 mils)

Description

The AMMC-6440 MMIC is a broadband 1W power amplifier designed for use in transmitters that operate in various frequency bands between 37GHz and 42GHz. This MMIC optimized for linear operation with an output third order intercept point (OIP3) of 38dBm. At 42GHz it provides 28dBm of output power (P-1dB) and 14dB of gain. The device has input and output matching circuitry for use in 50 Ω environments. The AMMC-6440 also integrates a temperature compensated RF power detection circuit that enables power detection of 0.25V/W. DC bias is simple and the device operates on widely available 5.5V for current supply (negative voltage only needed for Vg). It is fabricated in a PHEMT process for exceptional power and gain performance. For improved reliability and moisture protection, the die is passivated at the active areas.

Features

- Wide frequency range: 37 - 42 GHz
- High gain: 14 dB
- Power: @42 GHz, P-1dB=28 dBm
- Highly linear: OIP3=39dBm
- Integrated RF power detector
- 5.5 Volt, -0.7 Volt, 950mA operation

Applications

- Microwave Radio systems
- LMDS & Pt-Pt mmW Long Haul
- 802.16 & 802.20 WiMax BWA
- WLL and MMDS loops
- Can be driven by AMMC-6345, increasing overall gain



Note: These devices are ESD sensitive. The following precautions are strongly recommended. Ensure that an ESD approved carrier is used when dice are transported from one destination to another. Personal grounding is to be worn at all times when handling these devices

Absolute Maximum Ratings [AMMC-6440]

Symbols	Parameters	Units	Min.	Max.	Notes
Vd-Vg	Drain to Gate Voltage	V		8	
Vd	Positive Supply Voltage	V		5.5	
Vg	Gate Supply Voltage	V	-2.5	0.5	
Id	Drain Current	mA		TBD	2
PD	Power Dissipation	W		5.5	2, 3
Pin	CW Input Power	dBm		20	2
Tch	Operating Channel Temp	°C		+150	4
Tstg	Storage Case Temp.	°C		-65 to +155	
Tmax	Maximum Assembly Temp (30 sec max)	°C		+320	

Notes:
1. Operation in excess of any one of these conditions may result in permanent damage to this device. Functional operation at or near these limitations will significantly reduce the lifetime of the device.
2. Dissipated power PD is in any combination of DC voltage, Drain Current, input power and power delivered to the load.
3. When operated at maximum PD with a base plate temperature of 85 °C, the median time to failure (MTTF) is significantly reduced.
4. These ratings apply to each individual FET. The operating channel temperature will directly affect the device MTTF. For maximum life, it is recommended that junction temperatures (Tj) be maintained at the lowest possible levels. See MTTF vs. Channel temperature Table

AMMC-6440 DC Specifications/Physical Properties [1]

Symbol	Parameters and Test Conditions	Units	Min.	Typ.	Max.
I_d	Drain Supply Current (under any RF power drive and temperature) (V_d=5.5 V, V_g set for I_d Typical)	mA		950	1050
V_g	Gate Supply Operating Voltage ($I_{d(Q)}$ = 950 (mA))	V	-0.85	-0.7	-0.65
q_{ch-b}	Thermal Resistance [2] (Backside temperature, T_b = 25°C)	°C/W		6.4	

Notes:
1. Ambient operational temperature T_A=25°C unless otherwise noted.
2. Channel-to-backside Thermal Resistance (θ_{ch-b}) = 9.0°C/W at $T_{channel}$ (T_C) = 70°C as measured using infrared microscopy. Thermal Resistance at backside temperature (T_b) = 25°C calculated from measured data.

Thermal Properties

Parameter	Test Conditions	Value
Maximum Power Dissipation	Tbaseplate = 85°C	PD = 5.5W Tchannel = 150°C
Thermal Resistance (θjc)	Vd = 5.5V Id = 950mA PD = 5.23W Tbaseplate = 85°C	θjc = 6.4°C/W Tchannel = 118°C
Thermal Resistance (θjc) Under RF Drive	Vd = 5.5V Id = 1095mA Pout = 28dBm Pd = 5.43W Tbaseplate = 85°C	θjc = 6.4°C/W Tchannel = 120°C

MTTF vs. Tchannel Temperature

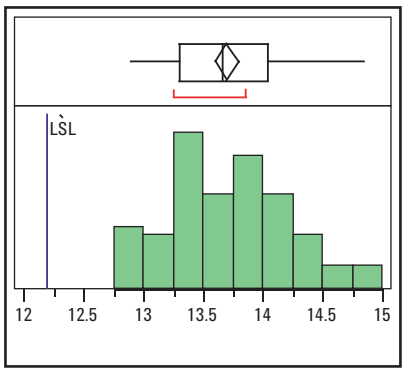
Operation	60% Confidence Level		90% Confidence Level		Point Data R=	
Tj	λ (ΦIT)	MTTF (hrs)	λ (ΦIT)	MTTF (hrs)	λ (ΦIT)	MTTF (Yrs)
150	3511	2.8E+05	8822	1.1E+05	3831	2.6E+05
140	1298	7.7E+05	3260	3.1E+05	1416	7.1E+05
130	456	2.2E+06	1147	8.7E+05	498	2.0E+05
120	152	6.6E+06	382	2.6E+06	166	6.0E+06
110	48	2.1E+07	120	8.3E+06	52	1.9E+06
100	14	7.0E+07	36	2.8E+07	15	6.5E+07
90	4	2.5E+08	10	1.0E+08	4	2.3E+08
80	1	9.9E+08	3	3.9E+08	1	9.1E+08
70	0	4.2E+09	1	1.7E+09	0	3.8E+09
60	0	1.9E+10	0	7.6E+09	0	1.7E+10
50	0	9.6E+10	0	3.8E+10	0	8.8E+10

AMMC-6440 RF Specifications [1, 2, 3]

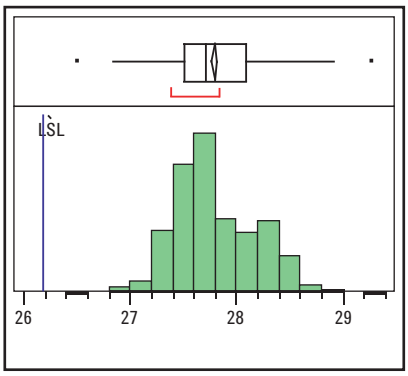
T_A= 25°C, V_d=5.5V, $I_{d(Q)=}$950 mA, Z_o=50 Ω

Symbol	Parameters and Test Conditions	Units	Minimum	Typical	Maximum	Sigma
Gain	Small-signal Gain[2]	dB	12	14		0.5
P_{-1dB}	Output Power at 1dB Gain Compression	dBm	26	28		0.39
P_{-3dB}	Output Power at 3dB Gain Compression	dBm		28.5		0.36
OIP3	Third Order Intercept Point; Δf=10MHz; Pin=-20dBm	dBm		38		0.86
RLin	Input Return Loss[2]	dB		-16		0.70
RLout	Output Return Loss[2]	dB		-18		0.71
Isolation	Min. Reverse Isolation	dB		-47		3.00

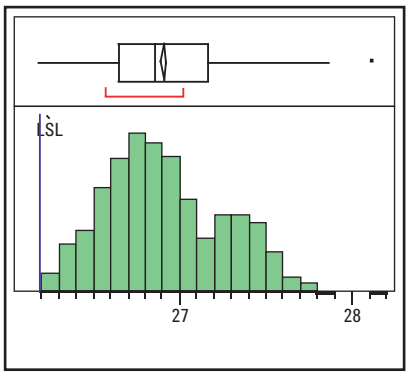
Notes:
3. Small/Large -signal data measured in wafer form T_A = 25°C.
4. 100% on-wafer RF test is done at frequency = 38, 40, and 42 GHz. Statistics based on 1500 part sample
5. Specifications are derived from measurements in a 50 Ω test environment. Aspects of the amplifier performance may be improved over a more narrow bandwidth by application of additional conjugate, linearity, or power matching.



Gain at 40 GHz



P-1dB at 40 GHz



P-1dB at 42 GHz

Typical distribution of Small Signal Gain and Output Power @P-1dB. Based on 1500 part sampled over several production lots.

AMMC-6440 Typical Performances (T_A = 25°C, V_d =5.5 V, I_D = 950 mA, Z_{in} = Z_{out} = 50 Ω)

NOTE: These measurements are in a 50 Ω test environment. Aspects of the amplifier performance may be improved over a more narrow bandwidth by application of additional conjugate, linearity, or power matching

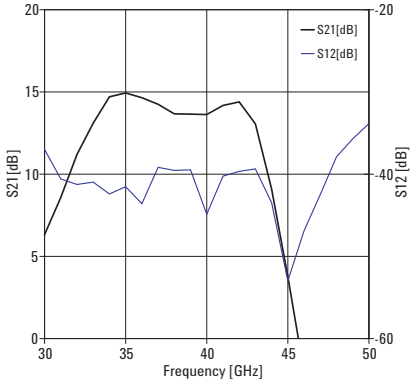


Figure 1. Typical Gain and Reverse Isolation

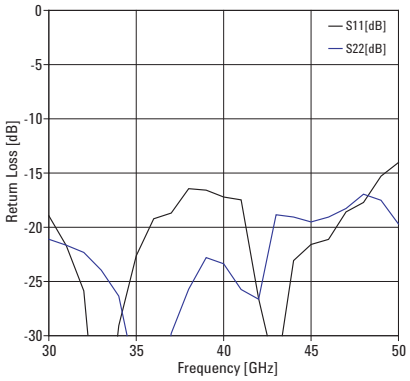


Figure 2. Typical Return Loss (Input and Output)

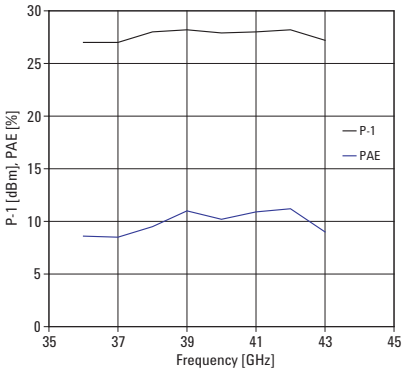


Figure 3. Typical Output Power (@P-1dB) and PAE

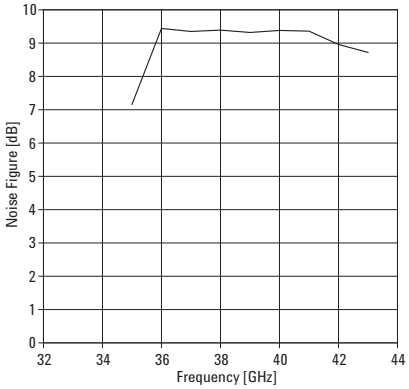


Figure 4. Typical Noise Figure

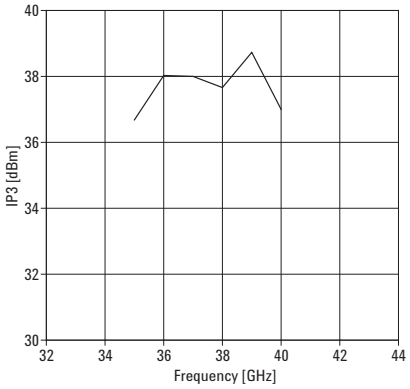


Figure 5. Typical Output 3rd Order Intercept Pt.

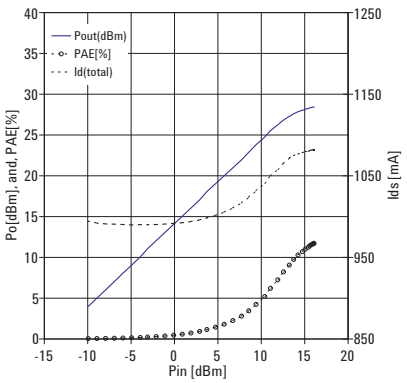


Figure 6. Typical Output Power, PAE, and Total Drain Current versus Input Power at40GHz

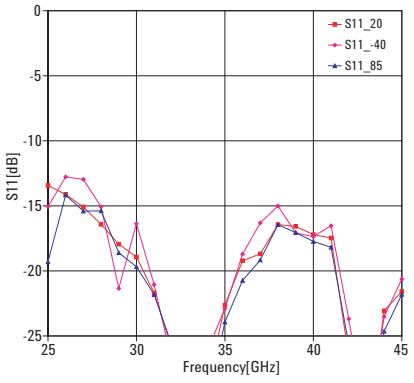


Figure 7. Typical S11 over temperature

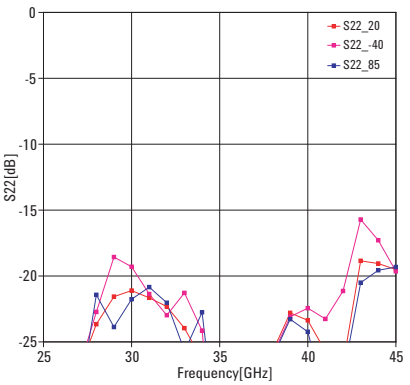


Figure 8. Typical S22 over temperature

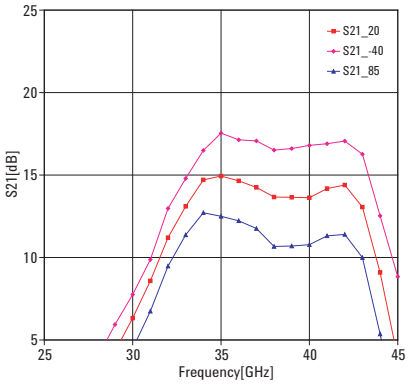


Figure 9. Typical Gain over temperature

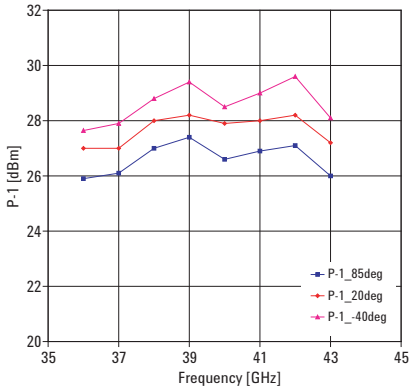


Figure 10. Typical One dB Compression over temperature

Typical Scattering Parameters [1], ($T_A = 25°C$, $V_d = 5.5$ V, $I_D = 950$ mA, $Z_{in} = Z_{out} = 50\ \Omega$)

Freq	S11			S21			S12			S22		
GHz	dB	Mag	Phase	dB	Mag	Phase	dB	Mag	Phase	dB	Mag	Phase
20	-8.26	0.39	35.28	-3.39	0.68	53.88	-51.52	2.66E-03	82.15	-10.41	0.30	-39.51
21	-9.55	0.33	18.31	-0.13	0.99	-32.46	-53.07	2.22E-03	58.35	-11.90	0.25	-54.15
22	-10.68	0.29	6.50	0.05	1.01	-98.82	-49.74	3.26E-03	107.10	-13.84	0.20	-67.90
23	-11.77	0.26	-4.14	-0.14	0.98	-151.54	-48.39	3.81E-03	136.45	-16.35	0.15	-82.69
24	-12.77	0.23	-11.52	-0.49	0.95	163.34	-43.49	6.69E-03	113.79	-20.06	0.10	-92.28
25	-13.43	0.21	-21.81	-0.41	0.95	125.97	-42.58	7.43E-03	103.95	-25.31	0.05	-93.95
26	-14.12	0.20	-31.29	0.24	1.03	90.59	-39.45	1.07E-02	92.03	-30.03	0.03	-54.19
27	-15.09	0.18	-41.60	1.14	1.14	56.21	-39.32	1.08E-02	84.03	-27.22	0.04	-20.99
28	-16.42	0.15	-51.56	2.48	1.33	21.78	-38.53	1.18E-02	61.72	-23.66	0.07	-16.14
29	-17.94	0.13	-62.21	4.32	1.64	-13.91	-40.36	9.60E-03	53.79	-21.56	0.08	-29.95
30	-18.94	0.11	-73.50	6.33	2.07	-51.69	-36.99	1.41E-02	44.78	-21.11	0.09	-42.93
31	-21.70	0.08	-82.94	8.58	2.69	-93.11	-40.58	9.35E-03	23.71	-21.65	0.08	-53.78
32	-25.86	0.05	-113.23	11.20	3.63	-140.25	-41.25	8.66E-03	27.01	-22.32	0.08	-67.31
33	-42.75	0.01	162.22	13.10	4.52	168.62	-40.97	8.95E-03	35.99	-23.96	0.06	-77.52
34	-29.08	0.04	80.83	14.71	5.44	113.57	-42.41	7.58E-03	18.07	-26.35	0.05	-118.70
35	-22.63	0.07	33.21	14.94	5.58	57.12	-41.53	8.39E-03	22.34	-34.08	0.02	-129.29
36	-19.22	0.11	21.46	14.65	5.40	4.18	-43.59	6.62E-03	42.99	-38.46	0.01	21.71
37	-18.69	0.12	15.80	14.25	5.16	-46.43	-39.17	1.10E-02	32.85	-29.79	0.03	95.54
38	-16.44	0.15	-2.06	13.67	4.82	-95.24	-39.54	1.05E-02	7.47	-25.71	0.05	49.06
39	-16.58	0.15	-19.18	13.65	4.81	-143.86	-39.47	1.06E-02	0.37	-22.80	0.07	32.40
40	-17.21	0.14	-37.99	13.63	4.80	167.35	-44.88	5.70E-03	11.79	-23.37	0.07	11.92
41	-17.47	0.13	-53.55	14.18	5.12	113.76	-40.24	9.72E-03	30.26	-25.74	0.05	-4.19
42	-26.58	0.05	-91.15	14.40	5.25	49.11	-39.66	1.04E-02	-4.22	-26.64	0.05	71.61
43	-33.75	0.02	110.21	13.06	4.50	-25.29	-39.36	1.08E-02	-12.55	-18.85	0.11	55.31
44	-23.07	0.07	40.34	9.09	2.85	-96.84	-43.48	6.70E-03	-17.47	-19.06	0.11	25.20
45	-21.59	0.08	23.11	3.77	1.54	-158.36	-52.98	2.24E-03	-26.13	-19.51	0.11	21.00
46	-21.12	0.09	22.94	-2.00	0.79	149.17	-46.88	4.53E-03	39.82	-19.06	0.11	20.89
47	-18.59	0.12	26.05	-7.54	0.42	105.77	-42.48	7.52E-03	69.08	-18.27	0.12	12.16
48	-17.71	0.13	23.21	-12.29	0.24	69.14	-37.89	1.27E-02	69.52	-16.95	0.14	6.57
49	-15.29	0.17	11.09	-16.78	0.14	36.42	-35.71	1.64E-02	14.63	-17.51	0.13	-11.50
50	-14.03	0.20	8.90	-20.84	0.09	8.48	-33.85	2.03E-02	35.67	-19.70	0.10	-24.97

Note:
Data obtained from on-wafer measurements.

Biasing and Operation

The recommended quiescent DC bias condition for optimum efficiency, performance, and reliability is Vd=5.5 volts with Vg set for Id=950 mA. Minor improvements in performance are possible depending on the application. The drain bias voltage range is 3 to 5.5V. A single DC gate supply connected to Vg will bias all gain stages. Muting can be accomplished by setting Vg and /or Vg to the pinch-off voltage Vp.

An optional output power detector network is also provided. The differential voltage between the Det-Ref and Det-Out pads can be correlated with the RF power emerging from the RF output port. The detected voltage is given by :

$V = (V_{ref} - V_{det}) - V_{ofs}$

where V_{ref} is the voltage at the *DET_R* port, V_{det} is a voltage at the *DET_O* port, and V_{ofs} is the zero-input-power offset voltage. There are three methods to calculate :

1. V_{ofs} can be measured before each detector measurement (by removing or switching off the power source and measuring). This method gives an error due to temperature drift of less than 0.01dB/50°C.
2. V_{ofs} can be measured at a single reference temperature. The drift error will be less than 0.25dB.
3. V_{ofs} can either be characterized over temperature and stored in a lookup table, or it can be measured at two temperatures and a linear fit used to calculate at any temperature. This method gives an error close to the method #1.

The RF ports are AC coupled at the RF input to the first stage and the RF output of the final stage. No ground wired are needed since ground connections are made with plated through-holes to the backside of the device.

Assembly Techniques

The backside of the MMIC chip is RF ground. For microstrip applications the chip should be attached directly to the ground plane (e.g. circuit carrier or heatsink) using electrically conductive epoxy [1,2].

For best performance, the topside of the MMIC should be brought up to the same height as the circuit surrounding it. This can be accomplished by mounting a gold plate metal shim (same length and width as the MMIC) under the chip which is of correct thickness to make the chip and adjacent circuit the same height. The amount of epoxy used for the chip and/or shim attachment should be just enough to provide a thin fillet around the bottom perimeter of the chip or shim. The ground plain should be free of any residue that may jeopardize electrical or mechanical attachment.

The location of the RF bond pads is shown in Figure 12. Note that all the RF input and output ports are in a Ground-Signal configuration.

RF connections should be kept as short as reasonable to minimize performance degradation due to undesirable series inductance. A single bond wire is normally sufficient for signal connections, however double bonding with 0.7 mil gold wire or use of gold mesh is recommended for best performance, especially near the high end of the frequency band.

Thermosonic wedge bonding is preferred method for wire attachment to the bond pads. Gold mesh can be attached using a 2 mil round tracking tool and a tool force of approximately 22 grams and a ultrasonic power of roughly 55 dB for a duration of 76 +/- 8 mS. The guided wedge at an untrasonic power level of 64 dB can be used for 0.7 mil wire. The recommended wire bond stage temperature is 150 +/- 2°C.

Caution should be taken to not exceed the Absolute Maximum Rating for assembly temperature and time.

The chip is 100um thick and should be handled with care. This MMIC has exposed air bridges on the top surface and should be handled by the edges or with a custom collet (do not pick up the die with a vacuum on die center).

This MMIC is also static sensitive and ESD precautions should be taken.

Notes:
1. Ablebond 84-1 LM1 silver epoxy is recommended.
2. Eutectic attach is not recommended and may jeopardize reliability of the device.

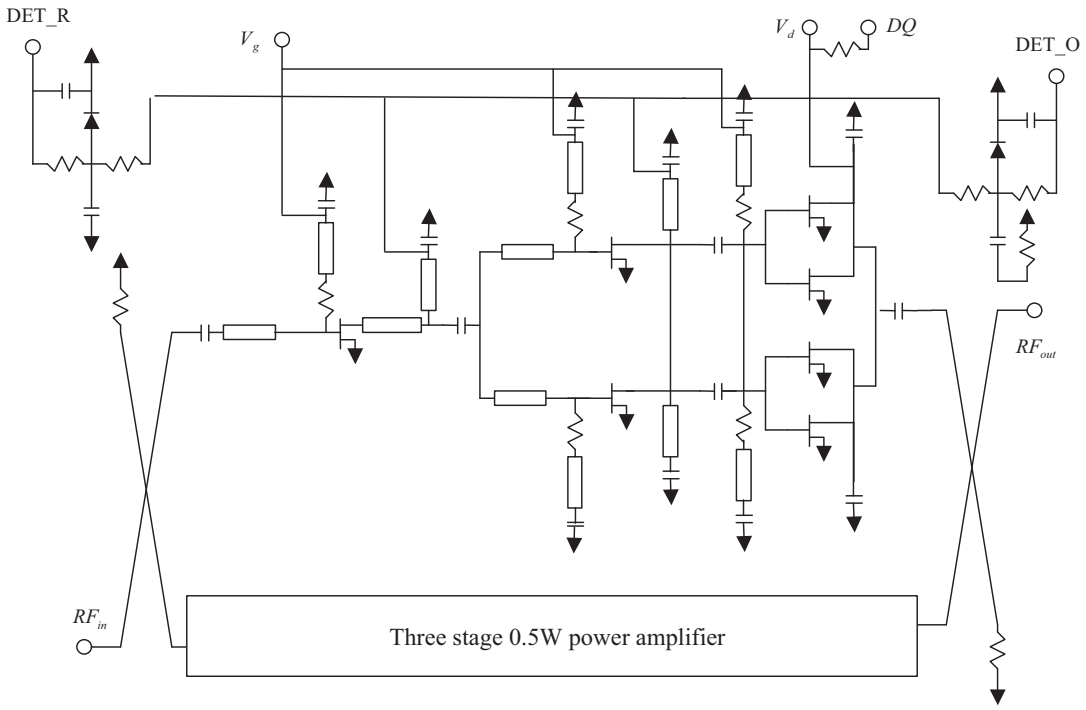


Figure 11. AMMC-6440 Schematic

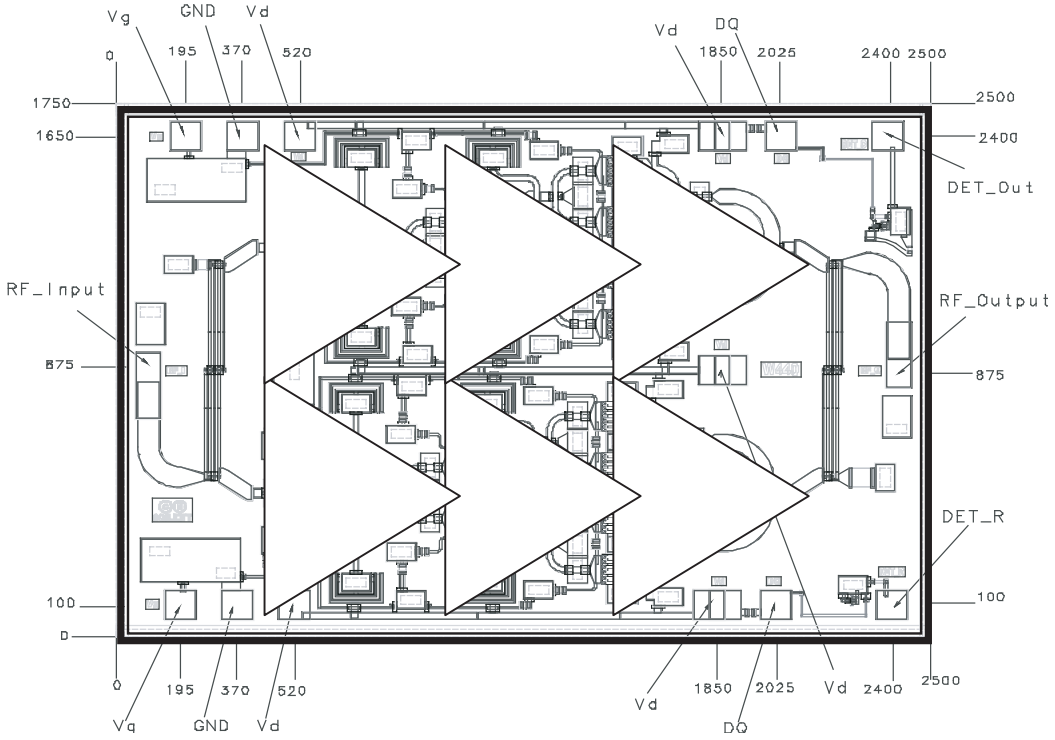
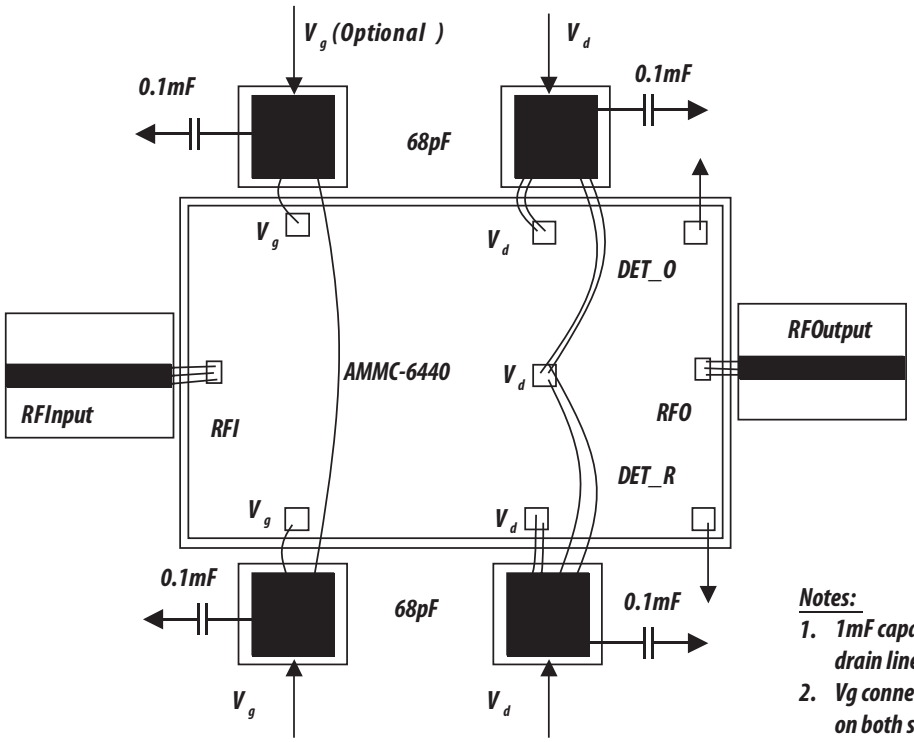


Figure 12. AMMC-6440 Bonding pad locations



Notes:

1. ***1mF capacitors on gate and drain lines not shown required.***
2. ***Vg connection is recommended on both sides for devices operating at or above P1dB.***

Figure 13. AMMC-6440 Assembly diagram

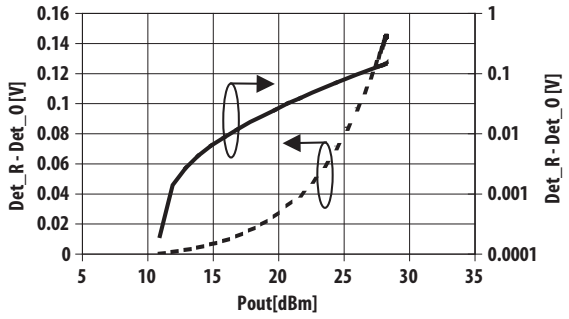


Figure 14. AMMC-6440 Typical Detector Voltage and Output Power, Freq=40 GHz

Ordering Information:

AMMC-6440-W10 = 10 devices per tray

AMMC-6440-W50 = 50 devices per tray

For product information and a complete list of distributors, please go to our web site: **www.avagotech.com**

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Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- *Конкурентоспособные цены и скидки постоянным клиентам.*
- *Специальные условия для постоянных клиентов.*
- *Подбор аналогов.*
- *Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.*

- *Приемлемые сроки поставки, возможна ускоренная поставка.*
- *Доставку товара в любую точку России и стран СНГ.*
- *Комплексную поставку.*
- *Работу по проектам и поставку образцов.*
- *Формирование склада под заказчика.*

- *Сертификаты соответствия на поставляемую продукцию (по желанию клиента).*
- *Тестирование поставляемой продукции.*
- *Поставку компонентов, требующих военную и космическую приемку.*
- *Входной контроль качества.*
- *Наличие сертификата ISO.*

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- *Регистрацию проекта у производителя компонентов.*
- *Техническую поддержку проекта.*
- *Защиту от снятия компонента с производства.*
- *Оценку стоимости проекта по компонентам.*
- *Изготовление тестовой платы монтаж и пусконаладочные работы.*

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